



12500 TI Boulevard, MS 8640, Dallas, Texas 75243

PCN# 20200323000.1

**Qualification of AIZU as an additional Fab Site option for select CMOS7 devices
Change Notification / Sample Request**

Date: March 23, 2020
To: Newark/Farnell PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

Texas Instruments requires acknowledgement of receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If samples or additional data are required, requests must be received within **30 days** of this notification.

The changes discussed within this PCN will not take effect any earlier than the proposed first ship date on Page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice or to provide acknowledgement of this PCN, you may contact your local Field Sales Representative or the PCN Team (PCN_ww_admin_team@list.ti.com). For sample requests or sample related questions, contact your local Field Sales Representative.

Sincerely,

PCN Team
SC Business Services



20200323000.1
Attachment: 1

Products Affected:

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE	CUSTOMER PART NUMBER
LM73CIMK-0/NOPB	null
LM73CIMKX-0/NOPB	null

Technical details of this Product Change follow on the next page(s).

PCN Number:	20200323000.1		PCN Date:	Mar 23, 2020																			
Title:	Qualification of AIZU as an additional Fab Site option for select CMOS7 devices																						
Customer Contact:	PCN Manager		Dept:	Quality Services																			
Proposed 1st Ship Date:	Jun 23, 2020		Estimated Sample Availability:	Date provided at sample request.																			
Change Type:																							
<input type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Assembly Process	<input type="checkbox"/>	Assembly Materials																		
<input type="checkbox"/>	Design	<input type="checkbox"/>	Electrical Specification	<input type="checkbox"/>	Mechanical Specification																		
<input type="checkbox"/>	Test Site	<input type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process																		
<input type="checkbox"/>	Wafer Bump Site	<input type="checkbox"/>	Wafer Bump Material	<input type="checkbox"/>	Wafer Bump Process																		
<input checked="" type="checkbox"/>	Wafer Fab Site	<input type="checkbox"/>	Wafer Fab Materials	<input type="checkbox"/>	Wafer Fab Process																		
		<input type="checkbox"/>	Part number change																				
PCN Details																							
Description of Change:																							
Texas Instruments is pleased to announce the qualification of its AIZU fabrication facility as an additional Wafer Fab source for the selected devices listed in "Product Affected" section.																							
<table border="1" style="width: 100%;"> <thead> <tr> <th colspan="3">Current Sites</th> <th colspan="3">Additional Sites</th> </tr> <tr> <th>Current Fab Site</th> <th>Process</th> <th>Wafer Diameter</th> <th>Additional Fab Site</th> <th>Process</th> <th>Wafer Diameter</th> </tr> </thead> <tbody> <tr> <td>MAINEFAB</td> <td>CMOS7</td> <td>200mm</td> <td>AIZU</td> <td>CMOS7</td> <td>200mm</td> </tr> </tbody> </table>						Current Sites			Additional Sites			Current Fab Site	Process	Wafer Diameter	Additional Fab Site	Process	Wafer Diameter	MAINEFAB	CMOS7	200mm	AIZU	CMOS7	200mm
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Current Fab Site	Process	Wafer Diameter	Additional Fab Site	Process	Wafer Diameter																		
MAINEFAB	CMOS7	200mm	AIZU	CMOS7	200mm																		
Qual details are provided in the Qual Data Section.																							
Reason for Change:																							
Continuity of Supply																							
Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):																							
None																							
Changes to product identification resulting from this PCN:																							
Current																							
Chip Site	Chip Site Origin (20L)	Chip Site Country Code (21L)	Chip Site City																				
MAINEFAB	CUA	USA	South Portland																				
New Fab Site																							
Chip Site	Chip Site Origin (20L)	Chip Site Country Code (21L)	Chip Site City																				
AIZU	CU2	JPN	Aizuwakamatsu-shi																				
Sample product shipping label (not actual product label)																							
<div style="display: flex; align-items: flex-start;"> <div style="flex: 1;">  <p>MADE IN: Malaysia 2DC: 20:</p> <table border="1"> <tr> <td>MSL 2 / 260C / 1 YEAR</td> <td>SEAL DT</td> </tr> <tr> <td>MSL 1 / 235C / UNLIM</td> <td>03/29/04</td> </tr> </table> <p>OPT: 39 ITEM: 39</p> <p>LBL: 5A (L)T0:1750</p> </div> <div style="flex: 1; text-align: center;">  </div> <div style="flex: 2;"> <p>(1P) SN74LS07NSR (Q) 2000 (D) 0336 (31T) LOT: 3959047MLA (4W) TKY (1T) 7523483SI2 (P) (2P) REV: (Y) 0033317 (20L) CS0: SHE (21L) CC0: USA (22L) AS0: MLA (23L) AC0: MYS</p> </div> </div>						MSL 2 / 260C / 1 YEAR	SEAL DT	MSL 1 / 235C / UNLIM	03/29/04														
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MSL 1 / 235C / UNLIM	03/29/04																						
Product Affected Group:																							
LM73CIMK-0/NOPB		LM73CIMKX-0/NOPB																					

Qualification Report

Approve Date 27-Jan-2020

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: LM73CIMKX0NOPB	QBS Process Reference: LM3668QDNTRQ1
PC	Preconditioning Level 1	Level 1 260C	1/320/0	3/800/0
HTOL	Life Test, 125C	1000 Hours	1/80/2 (Note 1)	3/231/0
AC	Autoclave 121C	96 Hours	1/77/0	-
UHA	Unbiased HAST 130C/85%RH	96 Hours	-	3/231/0
HAST	Biased HAST, 130C/85%RH	96 Hours	1/77/0	3/231/0
TC	Temperature Cycle, -65/150C	500CYC	1/77/0	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	1/77/0	-
HTSL	High Temp Storage Bake 150C	1000 Hours	-	3/231/0
HBM	ESD - HBM	1000 V	1/3/0	-
CDM	ESD - CDM	750 V	1/3/0	-
LU	Latch-up	Per JESD78	1/6/0	-
ED	Electrical Characterization	Per Datasheet Parameters	1/30/0	-
WBS	Wire Bond Shear	Cpk > 1.67	1/80/0	-
WBP	Wire Bond Pull	Cpk > 1.67	1/80/0	-

- QBS: Qual By Similarity

- Qual Device LM73CIMKX-0/NOPB is qualified at LEVEL 1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7 eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7 eV: 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

Green/Pb-free Status:

Qualified Pb-Free (SMT) and Green

Note1: Two units failed ATE after 1000 hours opline. Units failed due to data retention issue. Production bake was implemented to remove weak device at wafer sort

For questions regarding this notice, e-mails can be sent to the regional contacts shown below, or you can contact your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
WW PCN Team	PCN_ww_admin_team@list.ti.com

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